## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | PIETRASKI ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,601,214	07-2003	Hammons, Jr., A. Roger	714/790
*	В	US-6,665,813	12-2003	Forsman et al.	714/15
*	O	US-6,622,281	09-2003	Yun et al.	714/790
*	۵	US-2002/0027956	03-2002	Lee et al.	375/262
*	Е	US-7,076,726	07-2006	Yun et al.	714/790
*	F	US-2002/0141433	10-2002	Kwon et al.	370/441
*	G	US-2003/0007476	01-2003	Kim et al.	370/342
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	٦	US-			
•	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т	·				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.